

**Search Notes**

Application/Control No.

10/005,778

Examiner

Erin M. File

Applicant(s)/Patent under  
Reexamination

LI ET AL.

Art Unit

2634

**SEARCHED**

| Class | Subclass | Date       | Examiner |
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| 375   | 343      | 12/17/2004 | EMF      |
| 714   | 795      | 12/17/2004 | EMF      |
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**INTERFERENCE SEARCHED**

| Class | Subclass | Date | Examiner |
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**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

|  | DATE       | EXMR |
|--|------------|------|
| EAST US PAT, USPGPUB, EPO, JPO<br>DERWENT, IBM | 12/17/2004 | EMF  |
| PALM INVENTORSHIP                              | 12/17/2004 | EMF  |
| IEEE Explore Keyword Search                    | 12/20/2004 | EMF  |
| IEEE Explore Article Search                    | 12/20/2004 | EMF  |
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